

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
-40V	18mΩ@-10V	-20A
	25mΩ@-4.5V	

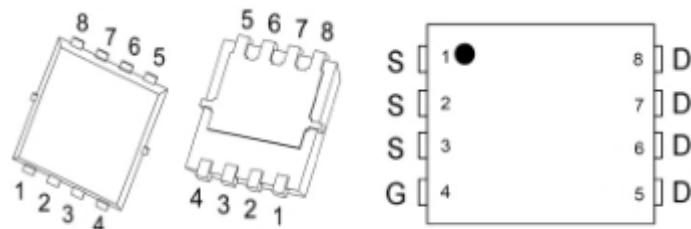
Feature

- TrenchFET Power MOSFET
- Excellent RDS(on) and Low Gate Charge

Applications

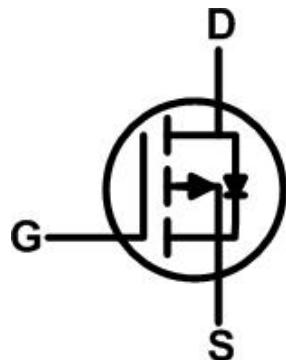
- Advanced trench process technology
- High density cell design for ultra-low on-resistance
- High power and current handing capability
- Ideal for Lion battery pack applications

Package

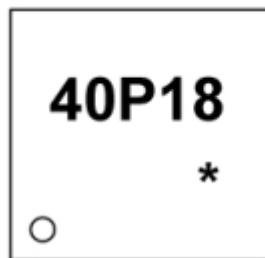


PDFNWB3.3×3.3-8L

Circuit diagram



Marking



40P18 = Device Code
* = Month Code

Absolute maximum ratings

($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	-20	A
Pulsed Drain Current	I_{DM}	-80	A
Power Dissipation	P_D	30	W
Thermal Resistance from Junction to Ambient ²⁾	$R_{\theta JA}$	4.17	$^\circ\text{C}/\text{W}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 To 150	$^\circ\text{C}$

Electrical characteristics

($T_A=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	$\text{BV}_{(\text{BR})\text{DSS}}$	$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$	-40			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -40\text{V}, V_{GS} = 0\text{V}$			-1	μA
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$			± 100	μA
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	-1.1	-1.7	-2.5	V
Drain-Source On-Resistance	$R_{DS(\text{on})}$	$V_{GS} = -10\text{V}, I_D = -5\text{A}$		18	26	$\text{m}\Omega$
		$V_{GS} = -4.5\text{V}, I_D = -5\text{A}$		25	35	
Forward Transconductance	g_{FS}	$V_{DS} = -5\text{V}, I_D = -5\text{A}$	20			S
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS} = -20\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$		1750		pF
Output Capacitance	C_{oss}			215		
Reverse Transfer Capacitance	C_{rss}			180		
Switching Characteristics						
Turn-on Delay Time	$T_{d(on)}$	$V_{DD} = -20\text{V}, R_L = 2\Omega, V_{GS} = -10\text{V}, R_G = 3\Omega$		9		nS
Turn-on Rise Time	T_r			8		
Turn-off Delay Time	$T_{d(off)}$			28		
Turn-off Fall Time	T_f			10		
Total Gate Charge	Q_g	$V_{DS} = -20\text{V}, I_D = -5\text{A}$		24		nC
Gate-Source Charge	Q_{gs}			3.5		
Gate-Drain Charge	Q_{gd}			6		
Drain-Source Diode Characteristics						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0\text{V}, I_S = -1\text{A}$			-1.2	V

Notes:

1. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
2. Guaranteed by design, not subject to production

Typical Characteristics

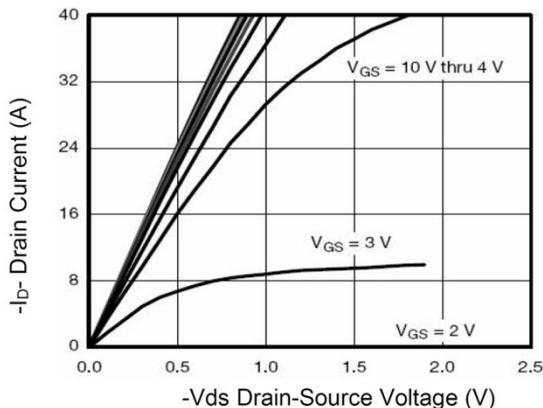


Figure 1 Output Characteristics

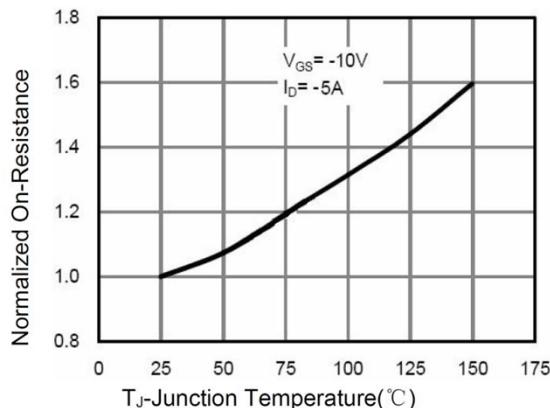


Figure 4 Rdson-Junction Temperature

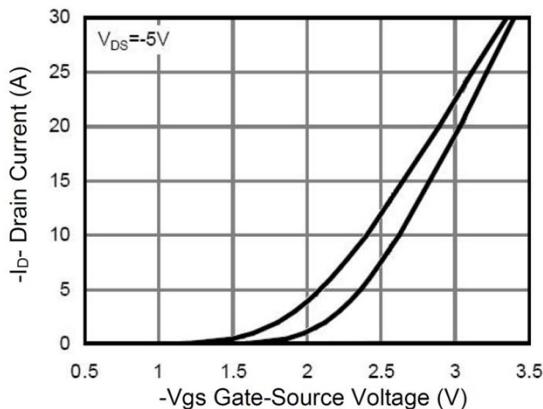


Figure 2 Transfer Characteristics

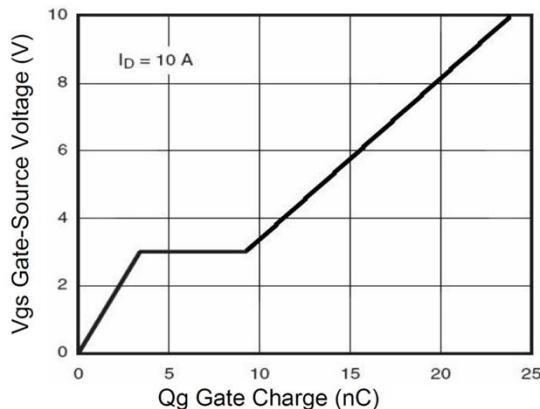


Figure 5 Gate Charge

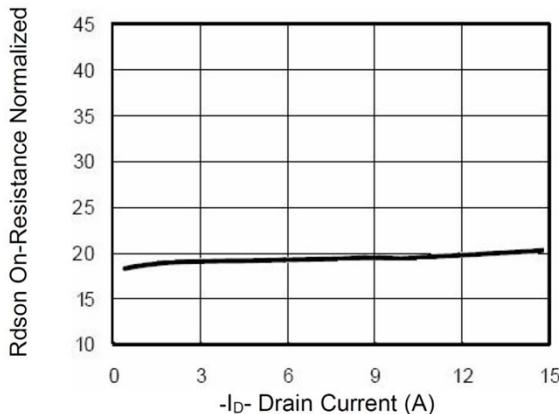


Figure 3 Rdson- Drain Current

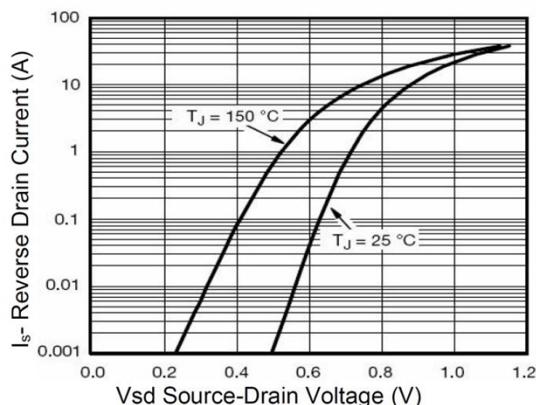


Figure 6 Source- Drift Diode Forward



ZL MOSFET

ZL40P18D

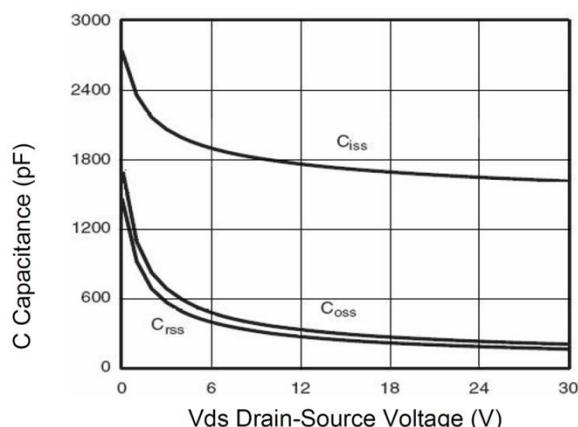


Figure 7 Capacitance vs Vds

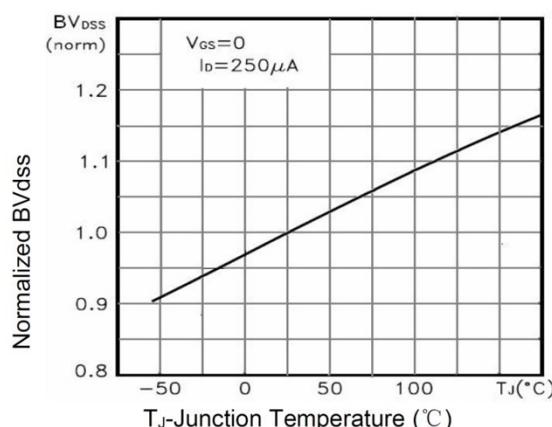
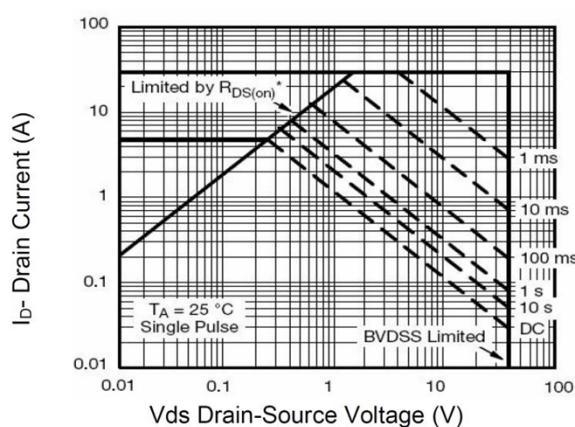
Figure 9 BV_{dss} vs Junction Temperature

Figure 8 Safe Operation Area

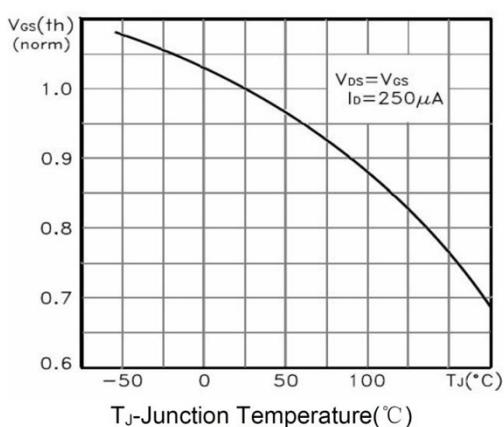
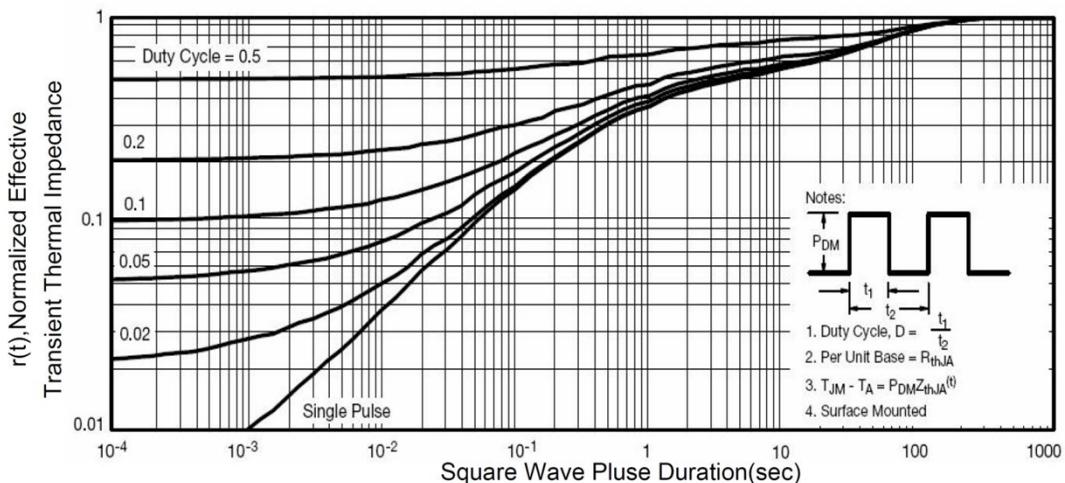
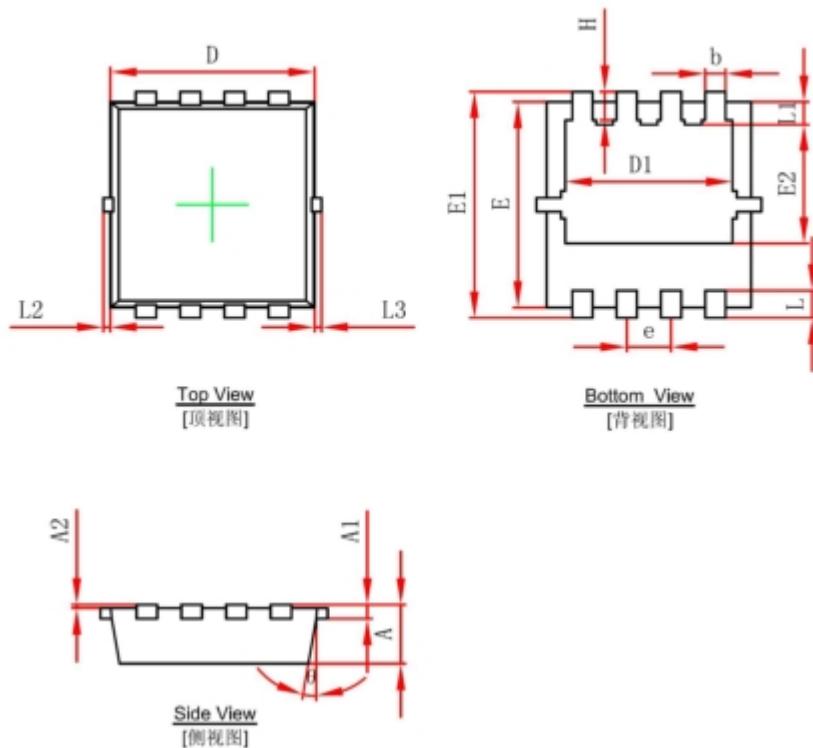
Figure 10 V_{gs(th)} vs Junction Temperature

Figure 11 Normalized Maximum Transient Thermal Impedance

PDFNWB3.3×3.3-8L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.650	0.850	0.026	0.033
A1	0.152 REF.			0.006 REF.
A2	0~0.05			0~0.002
D	2.900	3.100	0.114	0.122
D1	2.300	2.600	0.091	0.102
E	2.900	3.100	0.114	0.122
E1	3.150	3.450	0.124	0.136
E2	1.535	1.935	0.060	0.076
b	0.200	0.400	0.008	0.016
e	0.550	0.750	0.022	0.030
L	0.300	0.500	0.012	0.020
L1	0.180	0.480	0.007	0.019
L2	0~0.100			0~0.004
L3	0~0.100			0~0.004
H	0.315	0.515	0.012	0.020
θ	9°	13°	9°	13°